Search Notes			

Application/Control I	lo. Applicant(s)/Patent under Reexamination	
10/728,097	CHUNG ET AL.	
Examiner	Art Unit	
Nicholas Augustine	2179	

SEARCHED				
Class	Subclass	Date	Examiner	
715	744	1/7/2008	NA	
715	760	1/7/2008	NA	
718	1	1/7/2008	NA	
717	148	1/7/2008	NA	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Name Search	1/7/2008	NA	
East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	1/7/2008	NA	
NPL Search: IEEE XPlore; Google; Jux2; ACM; Proquest;Datastarweb	1/7/2008	NA	
electrical designation of the second	-		